

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination 10/643,186 SHEN ET AL.	
		Examiner	Art Unit	Page 1 of 1 Ke Xiao 2675

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C	US-6,636,286	10-2003	Baek, Heume-II	349/114
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

*	Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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